

Delft University of Technology

Avoiding concentration quenching and self-absorption in Cs_4EuX_6 (X = Br, I) by Sm^{2+} doping

van Aarle, Casper; Krämer, Karl W.; Dorenbos, Pieter

DOI 10.1039/d2tc05311j

Publication date 2023

Document Version Final published version

Published in Journal of Materials Chemistry C

Citation (APA) van Aarle, C., Krämer, K. W. & Dorenbos, P. (2023). Avoiding concentration quenching and self-absorption in Cs EuX (X = Br, I) by Sm²⁺ doping. *Journal of Materials Chemistry C*, *11*(6), 2336-2344. https://doi.8rg/10.1039/d2tc05311j

Important note

To cite this publication, please use the final published version (if applicable). Please check the document version above.

Copyright Other than for strictly personal use, it is not permitted to download, forward or distribute the text or part of it, without the consent of the author(s) and/or copyright holder(s), unless the work is under an open content license such as Creative Commons.

Takedown policy

Please contact us and provide details if you believe this document breaches copyrights. We will remove access to the work immediately and investigate your claim.

Journal of Materials Chemistry C

PAPER

Check for updates

Cite this: J. Mater. Chem. C, 2023, 11, 2336

Avoiding concentration quenching and self-absorption in Cs_4EuX_6 (X = Br, I) by Sm^{2+} doping

Casper van Aarle, 🝺 * a Karl W. Krämer 🕩 b and Pieter Dorenbos 🕩 a

The benefits of doping Cs_4EuBr_6 and Cs_4EuI_6 with Sm^{2+} are studied for near-infrared scintillator applications. It is shown that undoped Cs_4EuI_6 suffers from a high probability of self-absorption, which is almost completely absent in Cs_4EuI_6 :2% Sm. Sm^{2+} doping is also used to gain insight in the migration rate of Eu^{2+} excitations in Cs_4EuBr_6 and Cs_4EuI_6 , which shows that concentration quenching is weak, but still significant in the undoped compounds. Both self-absorption and concentration quenching are linked to the spectral overlap of the Eu^{2+} excitation and emission spectra which were studied between 10 K and 300 K. The scintillation characteristics of Cs_4EuI_6 :2% Sm is compared to that of the undoped samples. An improvement of energy resolution from 11% to 7.5% is found upon doping Cs_4EuI_6 with 2% Sm and the scintillation decay time shortens from 4.8 s to 3.5 s in samples of around 3 mm in size.

Received 13th December 2022, Accepted 18th January 2023

DOI: 10.1039/d2tc05311j

rsc.li/materials-c

1. Introduction

The energy resolution is a key parameter in the development of γ -ray spectrometers. It is defined as the full width at half maximum of the photopeak in a pulse height spectrum and is a measure of how accurately γ -rays from different energies can be resolved. Typically, scintillator energy resolutions are compared under detection of 662 keV γ -rays from a ¹³⁷Cs source. The current best energy resolution of 2.04% was achieved with LaBr₃:Ce,Sr, for which a light yield of 70 000 ph per MeV was reported.¹ The energy resolution of LaBr₃:Ce,Sr is close to the fundamental limit based on photon statistics, meaning significant improvements can only be made if more photons are detected in a scintillation event. This stresses the importance of developing high light yield scintillators. After the rediscovery of SrI₂:Eu in 2008,² SrI₂:Eu has been further developed resulting in an energy resolution of 2.6% and light yields of up to 115000 ph per MeV have been reported.3-7 Among other Eu²⁺-doped halides, the best energy resolution of 2.3% was achieved with CsBa₂I₅:Eu, with reported light yields up to 100 000 ph per MeV.⁸⁻¹¹ This shows that Eu²⁺-doped halides are potential candidates for achieving an energy resolution below 2%.

Despite these promising characteristics, Eu²⁺-doped scintillators still suffer from several drawbacks. Light yield and energy resolution typically tend to improve upon initial increase in Eu^{2+} concentration, but above several percent doping with Eu^{2+} these properties start to worsen again.¹²⁻¹⁶ This is at least in part caused by the large overlap between the Eu^{2+} excitation and emission spectrum, making Eu^{2+} -doped halides prone to concentration quenching and, in the case of large crystals, self-absorption.^{3,17,18}

Concentration quenching is caused by energy transfer between Eu^{2+} ions. This can take the form of consecutive transfer of a single excitation from one Eu^{2+} to another until it reaches a quenching site, or the excitation energy being lost by transfer to an already excited Eu^{2+} ion after which energy is lost due to relaxation back to the emitting state.^{19,20} Both these processes are strongly dependent on distance between Eu^{2+} ions and their effects can thus be diminished by increasing the distance between Eu^{2+} ions.²¹ Aside from reducing the amount of Eu^{2+} doping, this can also be achieved by selecting host compounds which intrinsically have larger distances between the divalent cation sites.

The compounds Cs_4MX_6 (M = Ca, Sr, Eu, Yb; X = Br, I) crystallize in the K_4CdCl_6 -type structure with space group $R\bar{3}c.^{22}$ They contain a single M^{2+} site with isolated $[MX_6]^{4-}$ octahedra, well separated from each other by Cs^+ cations. Accordingly, the smallest M–M distance of R = 9.0 Å in $Cs_4EuI_6^{22-24}$ is much longer than for corner-sharing perovkites with R = 6.2 Å in $CsEuI_3.^{25}$ When only considering the dipole–dipole interaction (scaling with $R^{-6\,21}$), the expected rate of energy transfer between Eu^{2+} nearest neighbours is around 10 times slower in Cs_4EuI_6 than it is in $CsEuI_3$. Contribution of the exchange interaction will make this difference even larger. Based on this,



View Article Online

View Journal | View Issue

^a Faculty of Applied Sciences, Delft University of Technology, Mekelweg 15, Delft, The Netherlands. E-mail: c.vanaarle@tudelft.nl

^b Department of Chemistry and Biochemistry, University of Bern, Freiestrasse 3, Bern, Switzerland

View Article Online

one would expect that Cs_4MX_6 compounds are much less affected by concentration quenching than their $CsMX_3$ counterparts, which is in line with the light yield increase reported by Wu *et al.* upon lowering the dimensionality of self-activated Cs_nEuI_{2+n} compounds.²⁴

Even though concentration quenching can be reduced by careful selection of the host lattice, the problem of selfabsorption remains, especially for high Eu²⁺ concentration and large crystal size. A solution of the Eu²⁺ self-absorption problem in scintillators is the co-doping with Sm²⁺. With an addition of as little as 1% Sm²⁺, close to 100% of Eu²⁺ excitations are transferred to Sm2+ and almost exclusively Sm2+ emission is observed.^{26,27} The Sm²⁺ 4f⁵5d \rightarrow 4f⁶ emission can end up in any of the $4f^{6}[{}^{7}F_{l}]$ states, while re-absorption can only take place from the $4f^{6}[^{7}F_{0}]$ ground state. Transitions to the $4f^{6}$ $[{}^{7}F_{1-6}]$ states result in longer wavelength emissions that are less likely to be re-absorbed by other Sm²⁺ ions. In combination with the relatively low Sm²⁺ concentration of around 1%, the probably of self-absorption in Eu²⁺ and Sm²⁺ co-doped materials is greatly reduced compared to scintillators in which Eu²⁺ is the emitting ion.28

In this work, the benefits of doping Cs_4EuBr_6 and Cs_4EuI_6 with Sm^{2+} are studied in an attempt to solve self-absorption and concentration quenching and thereby develop a nearinfrared scintillator. For this, Cs_4EuBr_6 and Cs_4EuI_6 samples were synthesizes with Sm^{2+} concentrations ranging from 0% to 2%. The amount of self-absorption is assessed for undoped and Sm^{2+} -doped Cs_4EuI_6 through X-ray excited emission and decay measurements. Energy transfer from Eu^{2+} to Eu^{2+} and from Eu^{2+} to Sm^{2+} is studied through photoluminescence spectroscopy and decay studies. Lastly, the scintillation performance is assessed through ^{137}Cs 662 keV γ -ray excited pulse height spectra.

2. Experimental techniques

Crystals of Cs₄EuBr₆, Cs₄EuI₆, and doped crystals with 0.5% and 2% Sm²⁺ were grown from the binary halides by the vertical Bridgman technique. CsBr (5N, Alfa) and CsI (suprapur, Merck) were dried in high vacuum at 200. EuBr2 and SmBr3 were prepared by the ammonium bromide method.²⁹ The rare earth oxide M_2O_3 (M = Eu, 5N, Metall Rare earth Ltd; M = Sm, > 3N, Fluka) was dissolved in concentrated HBr acid (suprapur, Merck) and an excess of NH₄ Br (pro analysis, sublimed, Merck) added in a M to NH₄ ratio of 2 to 7. The solution was dried up on a sand bath to yield the anhydrous ternary compound (NH₄)₃MBr₆, which is subsequently decomposed to the binary bromide by heating in vacuum. EuBr₂ was obtained at 500 °C and used without further purification. SmBr3 was sublimed at 650 °C in a silica apparatus under high vacuum for removal of SmOBr traces. SmBr₂ was obtained by reduction of SmBr₃ with Sm metal (3N; Alfa) in a Ta ampoule. The Ta-ampoule was sealed by helium arc-welding and enclosed into a silica ampoule under vacuum. The ampoule was heated to 900 °C for 7 days. The rare earth iodides were synthesized from the elements (Eu, 3N; Sm, 3N, both Alfa; I2, pro analysis, sublimed,

Merck) in sealed silica ampoules under vacuum. EuI₂ was obtained at 500 °C and purified by sublimation in an Au ampoule under vacuum at 900 °C. SmI₃ was prepared at 700 °C and sublimed for purification at 800 °C. SmI₂ was prepared from SmI₃ and Sm in a Ta ampoule 1 day at 900 °C and 7 days at 600 °C.

Stoichiometric amounts of the binary halides (about 5 g per sample) were sealed in Ta ampoules, as described above. The ampoules were heated in a Bridgman furnace to 560 °C, *i.e.*, above the congruent melting points of Cs_4EuBr_6 at 545 °C and Cs_4EuI_6 at 540 °C. After 1 day at constant temperature, the crystal growth was started by slowly moving up the furnace. The samples were cooled to RT within about 10 days. Crystals were cleaved from the boules for spectroscopic investigations. The denoted doping level represents the melt composition. Since staring materials and products are highly hygroscopic and sensitive to oxidation, all handling was done under strictly dry and oxygen-free conditions (H₂O and O₂ < 0.1 ppm) in glove boxes and sealed sample containers.

X-ray excited emission spectra were measured using an X-ray tube with tungsten anode, operated at 79 kV and aluminium filter to block low energy X-rays for preventing radiation damage at the sample surface. The samples were attached to the cold finger of a Janis VPF-700 cryostat. The emission coming from the sample under a 90 angle with respect to the X-ray beam was coupled into an optical fibre and read out with an Ocean insights QE Pro spectrometer.

X-ray excited decay curves were measured using a time correlated single photon counting method. A start signal was generated upon triggering a PicoQuant LDH-P-C-400M laser diode exciting a Hamamatsu N5084 light excited X-ray tube with tungsten anode operated at 40 kV, creating a 500 ps long pulse of X-rays. Upon detection of a scintillation photon by the ID Quantique ID100-50 single-photon detector, a stop signal was generated. The start and stop signals were processed using an Ortec 567 time-to-amplitude converter of which the output was connected to an Ortec AD114 16k analog-to-digital converter. The sample was attached to the cold finger of a Janis VPF-700 cryostat. The sample chamber was kept at a vacuum of 10^{-5} mbar to protect the hygroscopic sample from moisture.

¹³⁷Cs 662 keV γ-ray pulse height spectra of undoped samples were recorded using a R1791 photomultiplier tube (PMT) operated at a voltage of -700 V. The unpolished bare crystal was placed on the entrance window of the PMT and was covered with Teflon tape. No optical coupling was used. The number of photoelectrons created in a scintillation event was determined by comparing corresponding channel with the single electron response of the PMT. The light yield was calculated using the number of photoelectrons at the maximum of the 662 keV photopeak and correcting for the quantum efficiency and reflectivity of the PMT, using the method described by de Haas and Dorenbos.³⁰

¹³⁷Cs excited pulse height spectra of Sm²⁺-doped samples were recorded using an Advanced Photonix APD (type 630-70-72-510) operated at a bias voltage of 1690 V. The temperature of the APD was stabilised at 260 K. The APD signal was increased by a Cremit CR-112 pre-amplifier. The rest of the electronics are the same as used in the PMT set-up described above. The light yield was determined by comparing the channel of the photopeak with the peak from direct detection of 17.8 keV X-rays of ²⁴¹Am.

Photoluminescence excitation and emission spectra were measured using a 450 W Xenon lamp and a Horiba Gemini 180 monochromator to excite the sample. Light from the sample was collected at a 90 angle with respect to the incoming excitation light. Reflected excitation light was filtered out with an optical filter. The emission light passed through a Princeton Instruments SpectraPro-SP2358 monochromator, after which it was detected by a Hamamatsu R7600-20 PMT. The sample was attached to the cold finger of a closed cycle helium cryostat. Photoluminescence decay curves were recorded using an EKSPLA NT230 OPO laser to excite the sample with a repetition rate of 100 Hz and pulse duration of 10 ns. The emission passed through a Princeton Instruments SpectraPro-SP2358 monochromator and was detected by a Hamamatsu R7600U-20 PMT. An optical long pass filter was placed at the entrance of the monochromator to filter out the excitation light from the laser. The signal from the PMT was recorded using a CAEN DT5730 digitizer.

3. Results

Fig. 1a and b show the X-ray excited emission spectra between 78 K and 300 K of undoped Cs₄EuBr₆ and Cs₄EuI₆, respectively.

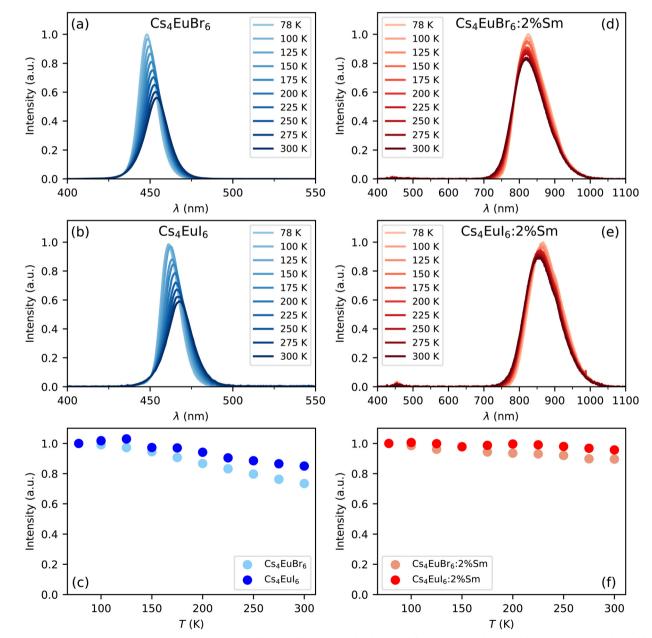


Fig. 1 X-ray excited emission spectra between 78 K and 300 K for (a) Cs_4EuBr_6 , (b) Cs_4EuI_6 , (d) Cs_4EuBr_6 :2% Sm and (e) Cs_4EuI_6 :2% Sm. (c) and (f) show the integrated emission intensities normalised to the intensity at 78 K.

Paper

Cs₄EuBr₆ shows a single emission band around 450 nm. This emission band is assigned to the Eu²⁺ 4f⁶ 5d \rightarrow 4f⁷ transition. With increasing temperature, the peak of the emission band shifts to longer wavelengths. This is typically observed in materials with high Eu²⁺ concentration and is ascribed to self-absorption.^{8,13,31} Cs₄EuI₆ also shows a single emission band that is assigned to the $Eu^{2+} 4f^6 5d \rightarrow 4f^7$ transition. The Eu²⁺ emission is located around 470 nm, at about 20 nm longer wavelength than for Cs₄EuBr₆. The emission band shows a similar shift to longer wavelengths with increasing temperature as was observed for Cs₄EuBr₆. The room temperature emission spectra of both samples correspond well to the data reported by Wu et al.²⁴ Fig. 1c shows the integrated emission intensity for Cs₄EuBr₆ and Cs₄EuI₆, normalised to their intensity at 78 K. The emission intensity of Cs₄EuBr₆ decreases by about 25% when temperature is increased from 78 K to 300 K. For Cs₄EuI₆, the emission intensity decreases by about 12%.

Fig. 1d and e show the X-ray excited emission spectra between 78 K and 300 K of Cs₄EuBr₆:2% Sm and Cs₄EuI₆:2% Sm, respectively. Cs4EuBr6:2% Sm shows a broad emission band around 820 nm, which is assigned to the Sm²⁺ 4f⁵5d \rightarrow 4f⁶ transitions. With increasing temperature, the peak of the emission band shifts to shorter wavelengths. This is likely caused by thermal expansion of the sample, decreasing the crystal field splitting and thereby elevating the lowest 5d level to higher energies. The observation of the emission peak shifting to shorter wavelengths indicates a low probability of selfabsorption of the Sm²⁺ emission. Cs₄EuI₆:2% Sm shows a similar broad emission band around 850 nm, which is also assigned to the $\rm Sm^{2+}~4f^55d~\rightarrow~4f^6$ transition. Also in this sample, the peak of the Sm²⁺ emission shifts to shorter wavelengths as temperature is increased. In both samples, a small amount of Eu²⁺ emission is visible between 400 nm and 500 nm. The integrated emission intensity of Cs₄EuBr₆:2% Sm and Cs₄EuI₆:2% Sm is shown in Fig. 1f. Upon increasing the temperature from 78 K to 300 K, the emission intensity remains almost constant compared to the decrease in intensity observed in the undoped samples.

Fig. 2a shows the X-ray excited decay curves of a $3 \times 3 \times 2 \text{ mm}^3 \text{Cs}_4\text{EuI}_6$ crystal between 78 K and 300 K. All decay curves show an initial fast component after which they converge to a single exponential of which the decay time increases with temperature. At 78 K, this decay time is 1.19 s and at 300 K it becomes 4 times slower with a decay time of 4.80 s. Fig. 2b shows the X-ray excited decay curves of a $4 \times 4 \times 3 \text{ mm}^3$ Cs₄EuI₆:2% Sm crystal between 78 K and 300 K. A 630 nm long pass filter was placed between the sample and the detector to remove the small amount of remaining Eu²⁺ emission. Unlike the decay curve of undoped Cs₄EuI₆, no fast component is observed in the decay curve. The decay time is also almost independent of temperature and increases marginally from 3.16 s at 78 K to 3.50 s at 300 K.

Fig. 3 shows the ¹³⁷Cs 662 keV γ -ray pulse height spectra of undoped Cs₄EuBr₆ and Cs₄EuI₆ recorded on a PMT. The photopeak of Cs₄EuBr₆ corresponds to 7500 photoelectrons being emitted from the photocathode of the PMT. Taking into

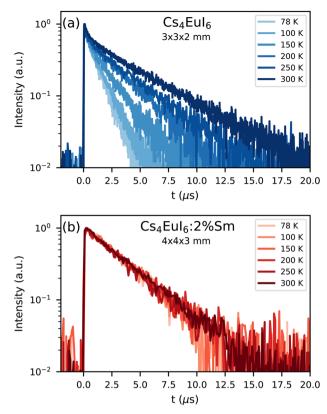


Fig. 2 X-ray excited decay curves between 78 K and 300 K of (a) $\rm Cs_4Eul_6$ and (b) $\rm Cs_4Eul_6:2\%$ Sm.

account the quantum efficiency (25%) and reflectivity (33%) of the PMT, the light yield is estimated around 30 200 ph per MeV. Scintillation events in the photopeak of Cs_4EuI_6 correspond to 5800 photoelectrons. At its emission wavelength of 470 nm, the quantum efficiency of the PMT is 22% and the reflectivity is 35%. This gives a light yield of 26 100 ph per MeV. Both samples have an energy resolution of 11%.

Fig. 4 shows the ¹³⁷Cs excited pulse height spectrum of $Cs_4EuI_6:2\%$ Sm recorded on an APD. In Fig. 4a, the pulse height spectrum is shown as recorded. On the *x*-axis, the number of

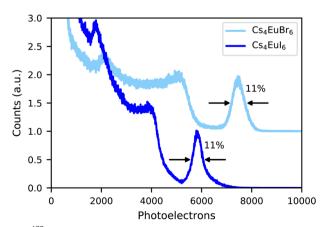


Fig. 3 ^{137}Cs excited pulse height spectra of Cs_4EuBr_6 and Cs_4EuI_6 measured on a PMT.

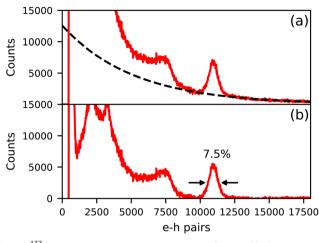


Fig. 4 137 Cs excited pulse height spectrum of Cs₄Eul₆:2% Sm measured on an APD. (a) Shows the spectrum as recorded and (b) shows the spectrum after background subtraction.

primary electron-hole pairs created in the APD during a scintillation event is set out, which is equal to the amount of detected scintillation photons. This pulse height spectrum contains a background of events that are caused by absorption of γ -rays directly in the APD. The dashed curve is an exponential approximation for this background and has been subtracted from the data to result in the pulse height spectrum displayed in Fig. 4b. On average, 11 000 photons are detected under the 662 keV photopeak, translating to a light yield of around 16 600 ph per MeV. An energy resolution of 7.5% has been attained. Fig. 5 shows the photoluminescence excitation (dashed curves) and emission (solid curves) spectra of undoped Cs_4EuBr_6 and Cs_4EuI_6 between 10 K and 300 K. As temperature is increased, both samples show an increase in emission bandwidth and the excitation spectra stretch to longer wavelengths. The result is an increase in spectral overlap between the Eu^{2+} emission and Eu^{2+} excitation. This increase in spectral overlap increases the probability that Eu^{2+} emission is re-absorbed by other Eu^{2+} , or that energy is transferred non-radiatively between neighbouring Eu^{2+} ions.

Fig. 6a shows the photoluminescence excitation and emission spectra of $Cs_4EuBr_6:0.5\%$ Sm at 300 K. Both the Eu^{2+} and $Sm^{2+} 5d \rightarrow 4f$ emission can be detected upon excitation at 350 nm, as shown by curve 1. The Eu^{2+} emission overlaps with the excitation spectrum of the Sm^{2+} emission (curve 3), which indicates that Eu^{2+} can transfer energy to Sm^{2+} . Between 200 nm and 400 nm, the excitation spectrum of the $Sm^{2+} 5d \rightarrow 4f$ emission shows the same bands as the excitation spectrum of the $Eu^{2+} 5d \rightarrow 4f$ emission (curve 2). This confirms that energy transfer from $Eu^{2+} to Sm^{2+}$ takes place.

In Fig. 6b, the photoluminescence excitation and emission spectra of $Cs_4EuI_6:0.5\%$ Sm are shown. Similar to $Cs_4EuBr_6:0.5\%$ Sm, it shows Eu^{2+} and Sm^{2+} 5d \rightarrow 4f emission upon excitation at 350 nm, as shown by curve 1. In this case though, the excitation spectrum of the Sm^{2+} emission (curve 3) shows dips where the excitation spectrum of the Eu^{2+} emission (curve 2) shows highest intensity. This indicates that energy transfer from Eu^{2+} to Sm^{2+} is inefficient, which is likely due to the low Sm^{2+} concentration is this sample.

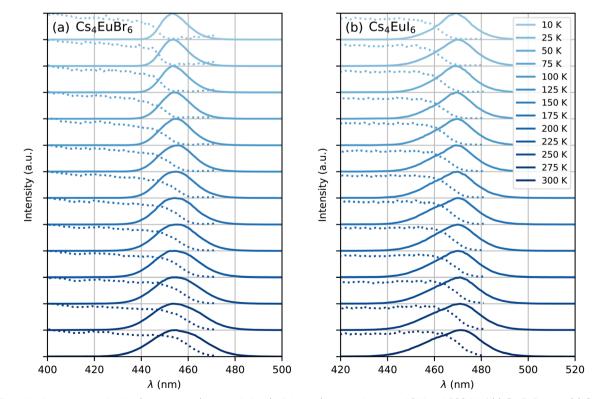


Fig. 5 Photoluminescence excitation (dotted curve) and emission (solid curve) spectra between 10 K and 300 K of (a) Cs₄EuBr₆ and (b) Cs₄EuBr₆.

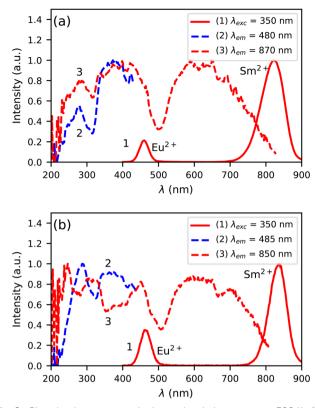


Fig. 6 Photoluminescence excitation and emission spectra at 300 K of (a) $Cs_4EuBr_6:0.5\%$ Sm and (b) $Cs_4EuI_6:0.5\%$ Sm.

Fig. 7 shows the photoluminescence decay of Eu^{2+} emission in (a) $Cs_4EuBr_6:0.5\%$ Sm, (b) $Cs_4EuBr_6:2\%$ Sm, (c) $Cs_4EuI_6:0.5\%$ Sm and (d) $Cs_4EuI_6:2\%$ Sm. All samples show approximately the same behaviour. All decay curves deviate from exponential functions, starting with fast decay and becoming slower as time progresses. The initial fast decay rate is only moderately dependent on temperature. The largest temperature dependence is found in the tail of the decay, making all temperature series fan out. This behaviour strongly resembles that of migrationally accelerated energy transfer, where Eu^{2+} excitations are able to move closer to Sm^{2+} by means of energy transfer between neighbouring Eu^{2+} ions.^{20,32} The initial rising component in the decay curves of Fig. 7a and b are caused by the laser pulse duration of approximately 10 ns.

The lifetime of Eu²⁺ excitations varies strongly between the samples. As the decay curves cannot be approximated with a single exponential function, the 1/e-decay time τ_e is reported. τ_e is defined as the time it takes for the decay curve to decrease by a factor of 1/e starting from its maximum intensity. Increasing the Sm²⁺ concentration in Cs₄EuBr₆ from 0.5% to 2% decreases τ_e from 20 ns to 16 ns. For Cs₄EuI₆, the same increase in Sm²⁺ concentration decreases τ_e from 172 ns to 44 ns. This decrease of τ_e with increasing Sm²⁺ concentration is expected, as a higher Sm²⁺ causes faster non-radiative energy transfer to Sm²⁺.

Fig. 8a and b show the photoluminescence decay of Eu^{2+} and Sm^{2+} emission in Cs_4EuBr_6 :2% Sm and Cs_4EuI_6 :2% Sm, respectively. The excitation wavelength is 350 nm, at which primarily

 Eu^{2+} is excited. The decay time of the Sm^{2+} emission is 2.82 s in Cs_4EuBr_6 :2% Sm and 3.26 s in Cs_4EuI_6 :2% Sm. The Eu^{2+} emission is strongly quenched by the presence of Sm^{2+} , therefore the inset shows the start of the decay curves on a shorter timescale. Here, it becomes visible that the Sm^{2+} emission intensity increases as the Eu^{2+} emission decays. This shows that excitations are transferred from Eu^{2+} to Sm^{2+} .

4. Discussion

Both self-absorption and non-radiative energy transfer significantly modify a luminescence decay curve. The luminescence decay can thus yield information on the energy transfer processes in the sample. The probability of both processes scales with the spectral overlap between the excitation band of the absorbing ion and the emission band of the emitting ion. In the case of Eu²⁺ it is shown by Fig. 5 that temperature induced broadening of the Eu²⁺ excitation and emission bands results in a significant change in spectral overlap between these bands when going from 10 K to 300 K. This increase in spectral overlap occurs both in Cs₄EuBr₆ and Cs₄EuI₆. Based on this, it is expected that the probability of self-absorption and the non-radiative energy transfer rate between neighbouring Eu²⁺ ions increase with temperature. Both these processes typically decrease the light yield of a scintillator, which is in line with the observed decrease of the emission intensity under X-ray excitation, as shown in Fig. 1c.

Fig. 2a shows the X-ray excited luminescence decay curves of Cs_4EuI_6 . The experiment was performed in reflection mode, *i.e.*, the detector was pointed to the surface of the sample illuminated by X-rays. With an average X-ray energy of around 10 keV, almost all X-rays are absorbed within the first 100 m below the sample surface; therefore almost all excitations of Eu²⁺ are present close to the surface on the side of the crystal oriented towards the detector. Light emitted into the direction of the detector has a low chance of being re-absorbed, thus the fast component visible in the first few microseconds gives an impression of the intrinsic radiative decay rate of Eu²⁺. The light which, after being emitted, travels deeper into the crystal has a high probability of being re-absorbed. The absorbed photons can be re-emitted into the direction of the detector and still contribute to the decay curve. The decay curve thereby converges to an exponential decay rate that is longer than the intrinsic radiative decay rate of Eu²⁺. This decay rate is given by $eqn (1)^{33}$:

$$\tau = \frac{\tau_{\rm r}}{1 - \eta a} \tag{1}$$

Here, τ_r is the radiative lifetime of the luminescence center, in this case Eu²⁺. η is the quantum efficiency of the luminescence center and *a* is the average probability that an emitted photon is re-absorbed. *a* increases with dopant concentration and size of the crystal. Values for τ and *a* are provided in Table 1 for the $3 \times 3 \times 2 \text{ mm}^3 \text{ Cs}_4\text{EuI}_6$ crystal, assuming $\eta = 1$. The value of τ_r was taken as 1.07 µs, which is the photoluminescence (PL) decay time at 10 K. It was assumed that self-absorption is

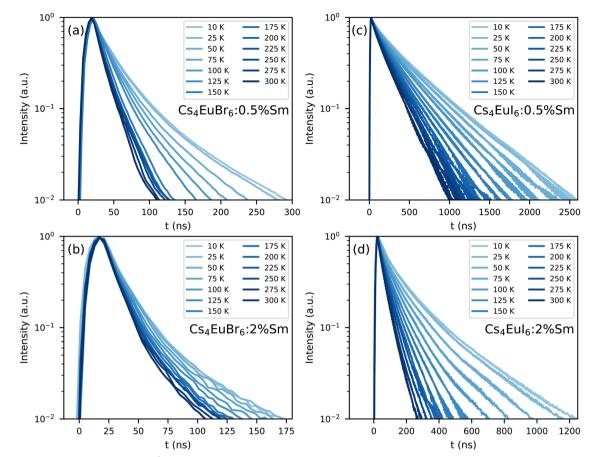


Fig. 7 Photoluminescence decay of the Eu^{2+} emission upon 400 nm excitation between 10 K and 300 K in (a) $Cs_4EuBr_6:0.5\%$ Sm, (b) $Cs_4EuBr_6:2\%$ Sm, (c) $Cs_4EuI_6:0.5\%$ Sm and (d) $Cs_4EuI_6:2\%$ Sm.

negligible under these conditions. This assumption is justified as the photoluminescence decay time at room temperature converges to the same value of around 1.0 µs upon decreasing the Eu²⁺ concentration to nearly 0% in Cs₄CaI₆ and Cs₄SrI₆.¹⁵ When increasing the temperature from 78 K to 300 K, τ increases from 1.19 s to 4.80 s and accordingly *a* increases from 0.10 to 0.78. This shows that even in a small crystal of 3 × 3 × 2 mm³, 78% of the emitted photons are re-absorbed.

In the same temperature range, the Sm²⁺ emission of the 4 × 4 × 3 mm³ Cs₄EuI₆:2% Sm sample shows only a marginal increase in τ from 3.16 s to 3.50 s. Using eqn (1), the value of *a* is calculated for every temperature step. The results are summarised in Table 1. Even though the Cs₄EuI₆:2% Sm crystal is significantly larger than the undoped Cs₄EuI₆ crystal, the values of *a* are around 10 times lower at every temperature. This shows that the low sensitivity of Sm²⁺ to self-absorption combined with the low Sm²⁺ concentration is an effective way to almost completely solve the self-absorption problem of Cs₄EuI₆.

As Eu^{2^+} transfers energy to Sm^{2^+} , doping the samples with Sm^{2^+} introduces a large amount of quenching sites for Eu^{2^+} . Insight in the non-radiative energy transfer rate between Eu^{2^+} ions can be attained by monitoring the photoluminescence decay of Eu^{2^+} in the Sm^{2^+} -doped samples, see Fig. 7. Directly after excitation of Eu^{2^+} , the Eu^{2^+} excitations are randomly distributed through the lattice. As the rate of non-radiative energy transfer scales with R^{-6} , excited Eu²⁺ ions that happen to be close to Sm²⁺ will transfer their energy to Sm²⁺ with higher probability than those at larger distance. Therefore the Eu²⁺ excitations will be depleted rapidly close to Sm²⁺. In this stage, corresponding to the first tens of nanoseconds of the decay curves, the rate at which Sm²⁺ can deplete the volume around it is the limiting factor in the decay rate of Eu²⁺. Once the volume around Sm²⁺ has been depleted, non-radiative energy transfer between Eu²⁺ ions will replenish the excitations in the depleted volumes. At this point, non-radiative energy transfer between Eu²⁺ ions becomes the limiting factor of the Eu²⁺ decay rate and causes the Eu²⁺ decay to slow down.

The rate at which Sm^{2+} depletes the Eu^{2+} excitations around it is almost independent of temperature, because the spectral overlap between the Eu^{2+} emission bands and the Sm^{2+} absorption bands does not change much with temperature. On the other hand, the rate of non-radiative energy transfer between Eu^{2+} ions does depend on temperature, because the spectral overlap between the Eu^{2+} excitation and emission spectra increases with temperature, see Fig. 5. This is also visible in Fig. 7; during the depletion of Eu^{2+} excitations close to Sm^{2+} in the first tens of nanoseconds after excitation, the Eu^{2+} emission decays with approximately the same rate at every temperature. As time further progresses into the hundreds of nanoseconds, non-radiative energy transfer between Eu^{2+} ions becomes the

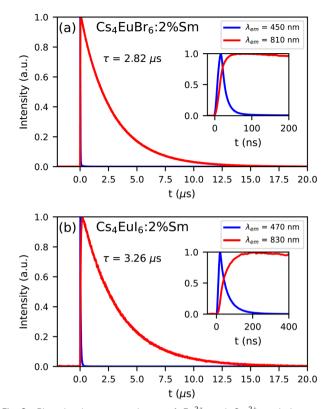


Fig. 8 Photoluminescence decay of Eu²⁺ and Sm²⁺ emission upon 350 nm excitation at 300 K in (a) Cs₄EuBr₆:2% Sm and (b) Cs₄EuI₆:2% Sm. The insets show the same decay curve on a shorter time scale.

Table 1 Decay times τ under X-ray excitation of Cs₄Eul₆ and Cs₄Eul₆:2% Sm single crystals and the average probability *a* a scintillation photon is reabsorbed inside the crystal. The first row shows the photoluminescence (PL) decay time at 10 K, which is taken as an approximation for the radiative lifetime τ_r

	$Cs_4EuI_6 (3 \times 3 \times 2 \text{ mm}^3)$		Cs ₄ EuI ₆ :2% Sm (4 × 4 × 3 mm ³)	
$T(\mathbf{K})$	τ (µs)	а	τ (µs)	а
10 (PL)	1.07	_	3.12	_
78	1.19	0.10	3.16	0.01
100	1.40	0.24	3.13	0.01
150	2.08	0.49	3.34	0.06
200	2.98	0.64	3.40	0.08
250	3.97	0.73	3.31	0.06
300	4.80	0.78	3.50	0.11

limiting factor of the Eu^{2+} decay; this results in a strong temperature dependence of the decay rate on longer timescales and the decay curves fan out.

The results in Fig. 7 show that a significant amount of energy transfer between Eu^{2+} ions is observed even for the isolated $[MX_6]^{4-}$ octahedra of Cs_4EuX_6 . The light yield reported for undoped Cs_4EuI_6 (53 000 ph per MeV)²⁴ is still significantly lower than that of the more diluted compounds Cs_4CaI_6 :7%Eu (69 000 ph per MeV) and Cs_4SrI_6 :9%Eu (78 000 ph per MeV),¹⁵ as reported by the same research group. When cooling Cs_4EuI_6 from 300 K to 78 K, the migration rate of the Eu^{2+} excitations

slows down while the light yield increases 10% to 20% (Fig. 1c). These observations strongly suggest that concentration quenching still plays a role in undoped Cs_4EuBr_6 and Cs_4EuI_6 .

Opposed to the undoped samples, $Cs_4EuBr_6:2\%$ Sm and $Cs_4EuI_6:2\%$ Sm show a much less significant change in intensity in the same temperature range, as shown by Fig. 1f. Once energy is transferred from Eu^{2+} to Sm^{2+} it cannot be transferred back to Eu^{2+} anymore. If the Sm^{2+} concentration is low enough, the distance between the Sm^{2+} ions is large and energy will not be transferred between Sm^{2+} ions. Aside from avoiding self-absorption, the doping of Eu^{2+} materials with Sm^{2+} effectively reduces concentration quenching.

Compared to the 2.1 s scintillation decay time of $CsBa_2I_5$:-Sm²⁺, the 3.5 s decay time of Cs_4EuI_6 :2% Sm is on the slow side for Sm²⁺-doped scintillators. However, due to the strong selfabsorption in undoped Cs_4EuI_6 , the decay time of Cs_4EuI_6 :2% Sm is already faster than that of undoped Cs_4EuI_6 with sample sizes of only a few mm. It is also fast enough for applications in γ -ray spectroscopy, as successfully shown by the pulse height spectrum in Fig. 4.

5. Conclusions

The benefits of doping Cs_4EuBr_6 and Cs_4EuI_6 with Sm^{2+} have been studied for applications in γ -ray spectroscopy. It has been demonstrated that undoped Cs_4EuI_6 suffers from strong selfabsorption. Despite the large distances between neighbouring Eu^{2+} ions, a small amount of concentration quenching has been observed in both Cs_4EuBr_6 and Cs_4EuI_6 . Self-absorption and concentration quenching originate from the spectral overlap between the Eu^{2+} excitation and emission spectra.

Both self-absorption and concentration quenching can be avoided by doping these scintillators with 2% Sm²⁺; this results almost exclusively in Sm²⁺ 4f⁵5d \rightarrow 4f⁶ emission. Due to the large amounts of self-absorption in the undoped samples, the room temperature scintillation decay time of the Sm²⁺ γ -doped Cs₄EuI₆ is already faster than that of small-size, undoped Cs₄EuI₆ crystals. The Sm²⁺ emission around 850 nm can be efficiently detected with an avalanche photodiode. Doping Cs₄EuI₆ with 2% Sm²⁺ improved the energy resolution from 11% to 7.5%.

Conflicts of interest

There are no conflicts of interest to declare.

Acknowledgements

This research was subsidized by the TTW/OTP grant no. 18040 of the Dutch Research Council. The authors would like to thank Daniel Biner, Bern, for the synthesis and crystal growth of the materials.

References

- M. S. Alekhin, J. T. M. de Haas, I. V. Khodyuk, K. W. Krämer, P. R. Menge, V. Ouspenski and P. Dorenbos, *Appl. Phys. Lett.*, 2013, **102**, 151915.
- 2 N. J. Cherepy, G. Hull, A. D. Drobshoff, S. A. Payne, E. Van Loef, C. M. Wilson, K. S. Shah, U. N. Roy, A. Burger, L. A. Boatner, W. S. Choong and W. W. Moses, *Appl. Phys. Lett.*, 2008, 92, 083508.
- 3 L. A. Boatner, J. O. Ramey, J. A. Kolopus, R. Hawrami, W. M. Higgins, E. van Loef, J. Glodo, K. S. Shah, E. Rowe, P. Bhattacharya, E. Tupitsyn, M. Groza, A. Burger, N. J. Cherepy and S. A. Payne, *J. Cryst. Growth*, 2010, **312**, 1213.
- 4 N. J. Cherepy, B. W. Sturm, O. B. Drury, T. A. Hurst, S. A. Sheets, L. E. Ahle, C. K. Saw, M. A. Pearson, S. A. Payne, A. Burger, L. A. Boatner, J. O. Ramey, E. V. Van Loef, J. Glodo, R. Hawrami, W. M. Higgins, K. S. Shah and W. W. Moses, *Proc. SPIE*, 2009, **7449**, 74490F.
- L. Alaribe, C. Disch, A. Fauler, R. Engels, E. Keller, A. Cecilia, T. Dos Santos Rolo, E. Hamann and M. Fiederle, *IEEE Trans. Nucl. Sci.*, 2012, 59, 2193.
- 6 R. Hawrami, J. Glodo, K. S. Shah, N. Cherepy, S. Payne, A. Burger and L. Boatner, *J. Cryst. Growth*, 2013, **379**, 69.
- Y. Wu, Q. Li, D. J. Rutstrom, I. Greeley, L. Stand, M. Loyd, M. Koschan and C. L. Melcher, *Nucl. Instrum. Methods Phys. Res., Sect. A*, 2020, 954, 161242.
- 8 M. S. Alekhin, D. A. Biner, K. W. Krämer and P. Dorenbos, *J. Lumin.*, 2014, **145**, 723.
- 9 G. Bizarri, E. D. Bourret-Courchesne, Z. Yan and S. E. Derenzo, *IEEE Trans. Nucl. Sci.*, 2011, **58**, 3403.
- E. D. Bourret-Courchesne, G. Bizarri, R. Borade, Z. Yan, S. M. Hanrahan, G. Gundiah, A. Chaudhry, A. Canning and S. E. Derenzo, *Nucl. Instrum. Methods Phys. Res., Sect. A*, 2009, 612, 138.
- 11 U. Shirwadkar, R. Hawrami, J. Glodo, E. V. D. van Loef and K. S. Shah, *IEEE Trans. Nucl. Sci.*, 2013, **60**, 1011.
- 12 K. Yang, M. Zhuravleva and C. L. Melcher, *Phys. Status Solidi RRL*, 2011, 5, 43.
- 13 Y. Wu, M. Zhuravleva, A. C. Lindsey, M. Koschan and C. L. Melcher, Nucl. Instrum. Methods Phys. Res., Sect. A, 2016, 820, 132.

- 14 J. Glodo, E. V. Van Loef, N. J. Cherepy, S. A. Payne and K. S. Shah, *IEEE T. Nucl. Sci.*, 2010, 57, 1228.
- 15 D. Rutstrom, L. Stand, M. Koschan, C. L. Melcher and M. Zhuravleva, J. Lumin., 2019, 216, 116740.
- 16 M. S. Alekhin, J. T. M. De Haas, K. W. Krämer and P. Dorenbos, *IEEE T. Nucl. Sci.*, 2011, 58, 2519.
- 17 M. S. Alekhin, K. W. Krämer and P. Dorenbos, Nucl. Instrum. Methods Phys. Res., Sect. A, 2013, 714, 13.
- 18 G. Gundiah, M. Gascón, G. Bizarri, S. E. Derenzo and E. D. Bourret-Courchesne, J. Lumin., 2015, 159, 274.
- 19 D. L. Dexter and J. H. Schulman, J. Chem. Phys., 1954, 22, 1063.
- 20 A. I. Burshtein, Phys.-Usp., 1984, 27, 579.
- 21 D. L. Dexter, J. Chem. Phys., 1953, 21, 836.
- 22 C. Ling, W. Meitian and W. Shishua, *J. Alloys Compd.*, 1997, **256**, 112.
- 23 L. Stand, M. Zhuravleva, B. Chakoumakos, J. Johnson, M. Loyd, Y. Wu, M. Koschan and C. L. Melcher, *J. Cryst. Growth*, 2018, 486, 162.
- 24 Y. Wu, D. Han, B. C. Chakoumakos, H. Shi, S. Chen, M. Du, I. Greeley, M. Loyd, D. J. Rutstrom, L. Stand, M. Koschan and C. L. Melcher, *J. Mater. Chem. C*, 2018, 6, 6647.
- 25 Cao Baopeng, Wang Shihua and Zhao Xinhua, J. Alloys Compd., 1992, 181, 511.
- 26 W. Wolszczak, K. W. Krämer and P. Dorenbos, *Phys. Status Solidi RRL*, 2019, **13**, 1900158.
- 27 C. van Aarle, K. W. Krämer and P. Dorenbos, *J. Lumin.*, 2021, 238, 118257.
- 28 R. H. P. Awater, M. S. Alekhin, D. A. Biner, K. W. Krämer and P. Dorenbos, *J. Lumin.*, 2019, **212**, 1.
- 29 G. Meyer, Advances in the Synthesis and Reactivity of Solids, JAI Press Inc., 1994, vol. 2, pp. 1–16.
- 30 J. T. M. De Haas and P. Dorenbos, *IEEE T. Nucl. Sci.*, 2008, 55, 1086.
- 31 L. Stand, M. Zhuravleva, G. Camarda, A. Lindsey, J. Johnson,
 C. Hobbs and C. L. Melcher, *J. Cryst. Growth*, 2016
 439, 93.
- 32 M. J. Weber, Phys. Rev. B: Solid State, 1971, 4, 2932.
- 33 W. Drozdowski and A. J. Wojtowicz, *Nucl. Instrum. Meth. A*, 2002, **486**, 412.